

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Prior Application: K. TAKIKAWA et al
Serial No. 09/785,499
Filed: February 20, 2001

Group Art Unit: 2836
Examiner: I. Rodriguez
For: SEMICONDUCTOR INTEGRATED
CIRCUIT DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

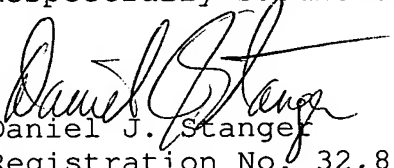
September 22, 2003

Sir:

In accordance with the duty of disclosure, the Applicants inform the Examiner of the documents cited during prosecution of the parent application, USSN 09/785,499.

The Applicants request the Examiner to initial and return a copy of the attached PTO-1449 form as an indication that the references have been considered.

Respectfully submitted,


Daniel J. Stanger
Registration No. 32,846
Attorney for Applicant(s)

MATTINGLY, STANGER & MALUR, P.C.
1800 Diagonal Road, Suite 370
Alexandria, Virginia 22314
Telephone: (703) 684-1120
Facsimile: (703) 684-1157
Date: September 22, 2003

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. H-963-02	SERIAL NO.		
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT K. TAKIKAWA et al			
				FILING DATE 09/22/03	GROUP 2836		
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>
	AA	6,518,815	02/2003	Grimaldi et al			
	AB	4,989,057	01/1991	Lu			
	AC	5,541,801	07/1996	Lee et al			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO
							YES NO
	AL	1-230266	09/13/89	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AM	7-202583	08/04/95	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AN						<input type="checkbox"/> <input type="checkbox"/>
	AO						<input type="checkbox"/> <input type="checkbox"/>
	AP						<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>							
	AR	HITACHI REVIEW, Vol. 81, No. 10, (1999-10), pp. 17-20.					
	AS						
	AT						
EXAMINER				DATE CONSIDERED			